

Notice of References Cited	Application/Control No. 10/783,522	Applicant(s)/Patent Under Reexamination LURIE ET AL.	
	Examiner PABLO WHALEY	Art Unit 1631	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0091666	07-2002	Rice et al.	707/1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Yao et al., IEEE International Conference on Control Applications, Sept. 2000, p.1-21
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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